ICS843801I-24

RENESAS FemtoClock[®] Crystal-to-3.3V, 2.5V LVPECL 400MHz Frequency Synthesizer

DATA SHEET

General Description

The ICS843801I-24 is a 400MHz Frequency Synthesizer. The ICS843801I-24 uses an 18pF parallel resonant crystal over the range of 21.5625MHz - 25.3125MHz. The ICS843801I-24 has excellent <1ps phase jitter performance, over the 12kHz - 20MHz integration range. The ICS843801I-24 is packaged in a small 8-pin TSSOP, making it ideal for use in systems with limited board space.

Features

- One differential 3.3V, 2.5V LVPECL output
- Crystal oscillator interface, 18pF parallel resonant crystal (21.5625MHz - 25.3125MHz)
- Output frequency range: 172.5MHz 202.5MHz, and 345MHz - 405MHz
- VCO range: 690MHz 810MHz
- RMS phase jitter at 400MHz, using a 25MHz crystal (12kHz – 20MHz): 0.88ps (typical), @ 3.3V
- Full 3.3V or 2.5V operating supply modes
- -40°C to 85°C ambient operating temperature
- Available in lead-free (RoHS 6) package

Common Configuration Table

	Ing	outs			
Crystal Frequency (MHz)	FREQ_SEL	М	N	Multiplication Value M/N	Output Frequency (MHz)
25	0	32	2	16	400
25	1 (default)	32	4	8	200

Block Diagram

Pin Assignment

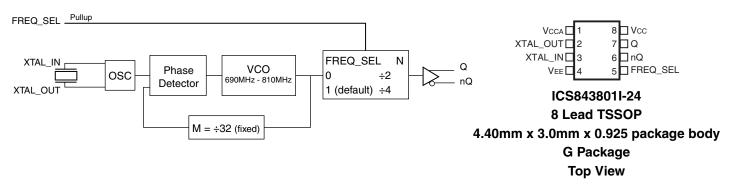


Table 1. Pin Descriptions

Number	Name	Т	уре	Description
1	V _{CCA}	Power		Analog supply pin
2, 3	XTAL_OUT XTAL_IN	Input		Crystal oscillator interface. XTAL_IN is the input, XTAL_OUT is the output.
4	V _{EE}	Power		Negative supply pin.
5	FREQ_SEL	Input	Pullup	Frequency select pin, LVCMOS/LVTTL interface levels.
6, 7	nQ, Q	Output		Differential output pair. LVPECL interface levels.
8	V _{CC}	Power		Core supply pin.

NOTE: Pullup refers to internal input resistors. See Table 2, Pin Characteristics, for typical values.

Table 2. Pin Characteristics

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
C _{IN}	Input Capacitance			4		pF
R _{PULLUP}	Input Pullup Resistor			51		kΩ

Absolute Maximum Ratings

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

Item	Rating
Supply Voltage, V _{CC}	4.6V
Inputs, V _I XTAL_IN Other Inputs	0V to V _{CC} -0.5V to V _{CC} + 0.5V
Outputs, I _O Continuos Current Surge Current	50mA 100mA
Package Thermal Impedance, θ_{JA}	129.5°C/W (0 mps)
Storage Temperature, T _{STG}	-65°C to 150°C

DC Electrical Characteristics

Table 3A. Power Supply DC Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to $85^{\circ}C$

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{CC}	Core Supply Voltage		3.135	3.3	3.465	V
V _{CCA}	Analog Supply Voltage		V _{CC} -0.09	3.3	V _{CC}	V
I _{CC}	Power Supply Current				66	mA
I _{CCA}	Analog Supply Current				9	mA
I _{EE}	Power Supply Current				72	mA

Table 3B. Power Supply DC Characteristics, V_{CC} = 2.5V \pm 5%, V_{EE} = 0V, T_{A} = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{CC}	Core Supply Voltage		2.375	2.5	2.625	V
V _{CCA}	Analog Supply Voltage		V _{CC} -0.09	2.5	V _{CC}	V
I _{CC}	Power Supply Current				60	mA
I _{CCA}	Analog Supply Current				9	mA
I _{EE}	Power Supply Current				72	mA

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V	Input High Voltage	$V_{CC} = 3.3V$	2		V _{CC} + 0.3	V
V _{IH}	input high voltage	$V_{CC} = 2.5V$	1.7		V _{CC} + 0.3	V
V	Input Low Voltage	$V_{CC} = 3.3V$	-0.3		0.8	V
V _{IL}	Input Low Voltage	$V_{CC} = 2.5V$	-0.3		0.7	V
I _{IH}	Input High Current	$V_{CC} = V_{IN} = 3.465 V \text{ or } 2.625 V$			5	μA
IIL	Input Low Current	V_{CC} = 3.465V or 2.625V, V_{IN} = 0V	-150			μA

Table 3C. LVCMOS/LVTTL DC Characteristics, V_{CC} = $3.3V \pm 5\%$ or $2.5V \pm 5\%$, V_{EE} = 0V, T_A = -40°C to 85° C

Table 3D. LVPECL DC Characteristics, V_{CC} = 3.3V \pm 5%, V_{EE} = 0V, T_{A} = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage; NOTE 1		V _{CC} – 1.4		V _{CC} – 0.9	V
V _{OL}	Output Low Voltage; NOTE 1		V _{CC} – 2.0		V _{CC} – 1.7	V
V _{SWING}	Peak-to-Peak Output Voltage Swing		0.6		1.0	V

NOTE 1: Outputs termination with 50 Ω to V_CC – 2V.

Table 3E. LVPECL DC Characteristics, V_{CC} = 2.5V \pm 5%, V_{EE} = 0V, T_{A} = -40°C to 85°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
V _{OH}	Output High Voltage; NOTE 1		V _{CC} – 1.4		V _{CC} – 0.9	V
V _{OL}	Output Low Voltage; NOTE 1		V _{CC} – 2.0		V _{CC} – 1.5	V
V _{SWING}	Peak-to-Peak Output Voltage Swing		0.4		1.0	V

NOTE 1: Outputs termination with 50Ω to V_{CC} – 2V.

Table 4. Crystal Characteristics

Parameter	Test Conditions	Minimum	Typical	Maximum	Units
Mode of Oscillation	Fundamental				
Frequency		21.5625		25.3125	MHz
Equivalent Series Resistance (ESR)				50	Ω
Shunt Capacitance				7	pF

AC Electrical Characteristics

Table 5A. AC Characteristics, $V_{CC} = 3.3V \pm 5\%$, $V_{EE} = 0V$, $T_A = -40^{\circ}C$ to 85°

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
4			172.5		202.5	MHz
fout	Output Frequency		345		405	MHz
fiit(0)	RMS Phase Jitter, Random;	200MHz, Integration Range: 12kHz – 20MHz		0.87	1.02	ps
<i>t</i> jit(Ø)	NOTE 1	400MHz, Integration Range: 12kHz – 20MHz		0.88	0.98	ps
<i>t</i> jit(cc)	Cycle-to-Cycle Jitter; NOTE 2				13	ps
<i>t</i> jit(per)	RMS Period Jitter			0.18	2.1	ps
tL	PLL Lock Time				10	ms
t _R / t _F	Output Rise/Fall Time	20% to 80%	200		500	ps
odc	Output Duty Cycle		48		52	%

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 1: Refer to Phase Noise Plots.

NOTE 2: These parameters are guaranteed by characterization. Not tested in production.

Table 5B. AC Characteristics, V_{CC} = 2.5V ± 5%, V_{EE} = 0V, T_A = -40°C to 85°

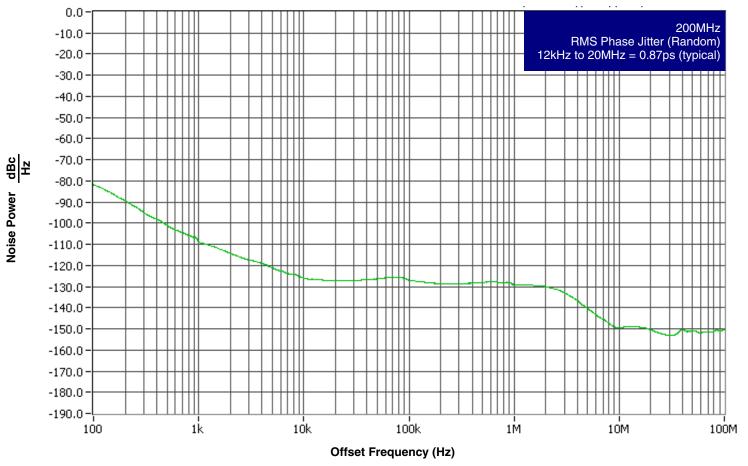
Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
£	Output Frequency		172.5		202.5	MHz
fout			345		405	MHz
fiit(<i>(</i> ())	RMS Phase Jitter, Random;	200MHz, Integration Range: 12kHz – 20MHz		0.87	1.05	ps
<i>t</i> jit(Ø)	NOTE 1	400MHz, Integration Range: 12kHz – 20MHz		0.89	1.06	ps
<i>t</i> jit(cc)	Cycle-to-Cycle Jitter; NOTE 2				16	ps
<i>t</i> jit(per)	RMS Period Jitter			0.20	2.6	ps
tL	PLL Lock Time				10	ms
t _R / t _F	Output Rise/Fall Time	20% to 80%	200		500	ps
odc	Output Duty Cycle		48		52	%

NOTE: Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

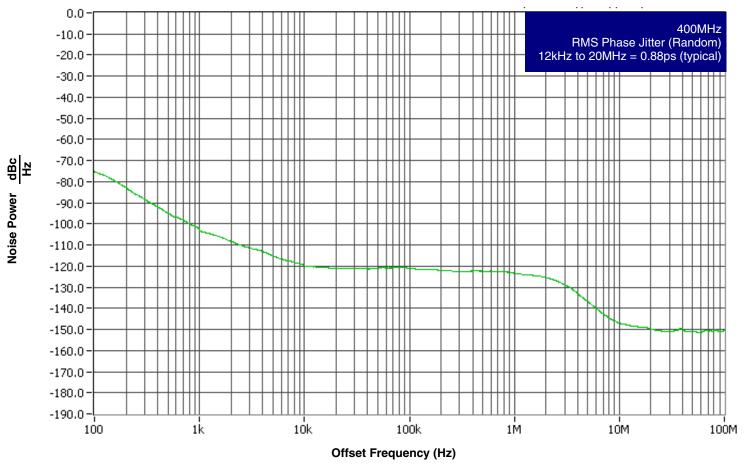
NOTE 1: Refer to Phase Noise Plots.

NOTE 2: These parameters are guaranteed by characterization. Not tested in production.

Typical Phase Noise at 200MHz, (3.3V)

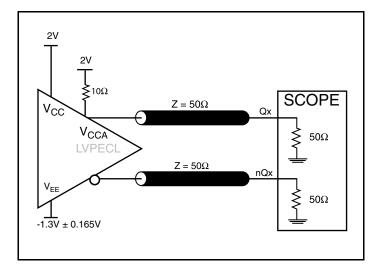


Typical Phase Noise at 400MHz, (3.3V)

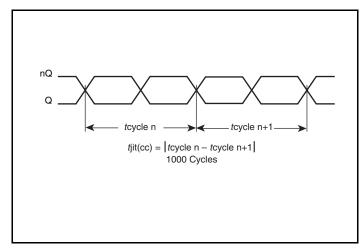


RENESAS

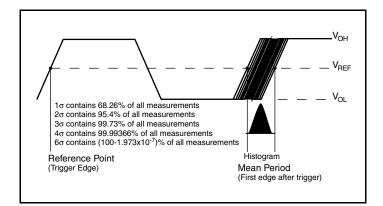
Parameter Measurement Information



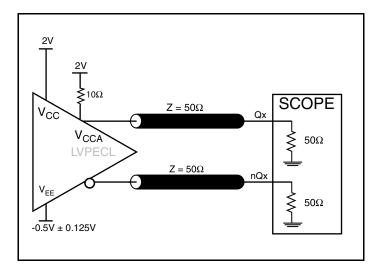
3.3V Core/ 3.3V LVPECL Output Load AC Test Circuit



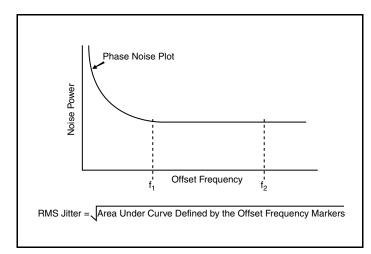
Cycle-to-Cycle Jitter



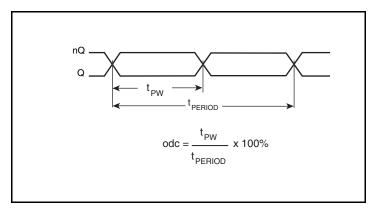




2.5V LVPECL Output Load AC Test Circuit



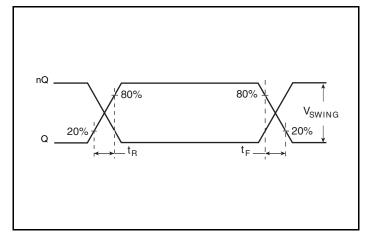
RMS Phase Jitter



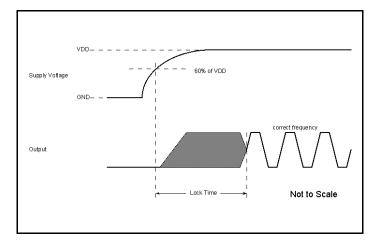
Output Duty Cycle/Pulse Width/Period

RENESAS

Parameter Measurement Information, continued



Output Rise/Fall Time



PLL Lock Time

Applications Information

Overdriving the XTAL Interface

The XTAL_IN input can accept a single-ended LVCMOS signal through an AC coupling capacitor. A general interface diagram is shown in *Figure 1A*. The XTAL_OUT pin can be left floating. The maximum amplitude of the input signal should not exceed 2V and the input edge rate can be as slow as 10ns. This configuration requires that the output impedance of the driver (Ro) plus the series resistance (Rs) equals the transmission line impedance. In addition,

matched termination at the crystal input will attenuate the signal in half. This can be done in one of two ways. First, R1 and R2 in parallel should equal the transmission line impedance. For most 50Ω applications, R1 and R2 can be 100Ω . This can also be accomplished by removing R1 and making R2 50Ω . By overdriving the crystal oscillator, the device will be functional, but note, the device performance is guaranteed by using a quartz crystal.

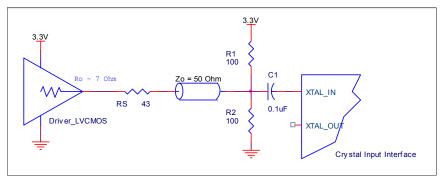


Figure 1A. General Diagram for LVCMOS Driver to XTAL Input Interface

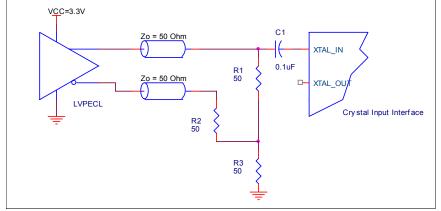


Figure 1B. General Diagram for LVPECL Driver to XTAL Input Interface

Termination for 3.3V LVPECL Outputs

The clock layout topology shown below is a typical termination for LVPECL outputs. The two different layouts mentioned are recommended only as guidelines.

The differential outputs are low impedance follower outputs that generate ECL/LVPECL compatible outputs. Therefore, terminating resistors (DC current path to ground) or current sources must be used for functionality. These outputs are designed to drive 50Ω

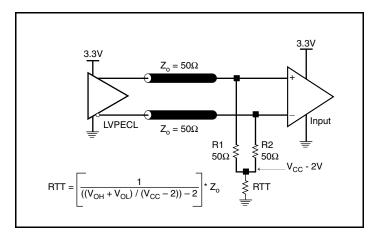


Figure 2A. 3.3V LVPECL Output Termination

transmission lines. Matched impedance techniques should be used to maximize operating frequency and minimize signal distortion. *Figures 2A and 2B* show two different layouts which are recommended only as guidelines. Other suitable clock layouts may exist and it would be recommended that the board designers simulate to guarantee compatibility across all printed circuit and clock component process variations.

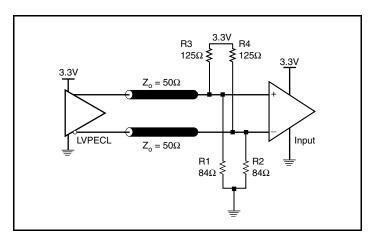


Figure 2B. 3.3V LVPECL Output Termination

Termination for 2.5V LVPECL Outputs

Figure 3A and *Figure 3B* show examples of termination for 2.5V LVPECL driver. These terminations are equivalent to terminating 50 Ω to V_{CO} – 2V. For V_{CC}= 2.5V, the V_{CC}– 2V is very close to ground

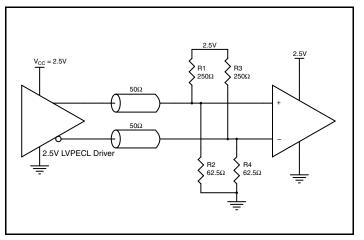


Figure 3A. 2.5V LVPECL Driver Termination Example

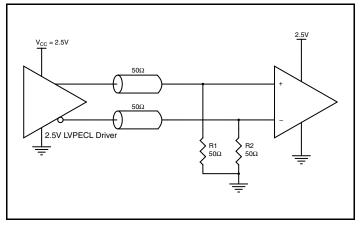


Figure 3C. 2.5V LVPECL Driver Termination Example

level. The R3 in Figure 3B can be eliminated and the termination is shown in *Figure 3C*.

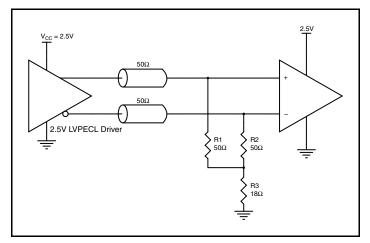


Figure 3B. 2.5V LVPECL Driver Termination Example

Schematic Example

Figure 4 shows an example of ICS8438011-24 application schematic. In this example, the device is operated at $V_{CC} = V_{CCA} = 3.3V$. The 18pF parallel resonant 25MHz crystal is used. The load capacitance C1 = 22pF and C2 = 22pF are recommended for frequency accuracy. Depending on the parasitic of the printed circuit board layout, these values might require a slight adjustment to optimize the frequency accuracy. Crystals with other load capacitance specifications can be used. This will require adjusting C1 and C2

As with any high speed analog circuitry, the power supply pins are vulnerable to random noise. To achieve optimum jitter performance, power supply isolation is required. The ICS843801I-24 provides separate power supplies to isolate any high switching noise from coupling into the internal PLL.

In order to achieve the best possible filtering, it is recommended that the placement of the filter components be on the device side of the PCB as close to the power pins as possible. If space is limited, the $0.1\mu F$ capacitor in each power pin filter should be placed on the

device side of the PCB and the other components can be placed on the opposite side.

Power supply filter recommendations are a general guideline to be used for reducing external noise from coupling into the devices. The filter performance is designed for wide range of noise frequency. This low-pass filter starts to attenuate noise at approximately 10kHz. If a specific frequency noise component with high amplitude interference is known, such as switching power supplies frequencies, it is recommended that component values be adjusted and if required, additional filtering be added. Additionally general design practice for power plane voltage stability suggests adding bulk capacitances in the general area of all devices.

The schematic example focuses on functional connections and is not configuration specific. Refer to the pin description and functional tables in the datasheet to ensure the logic control inputs are properly set.

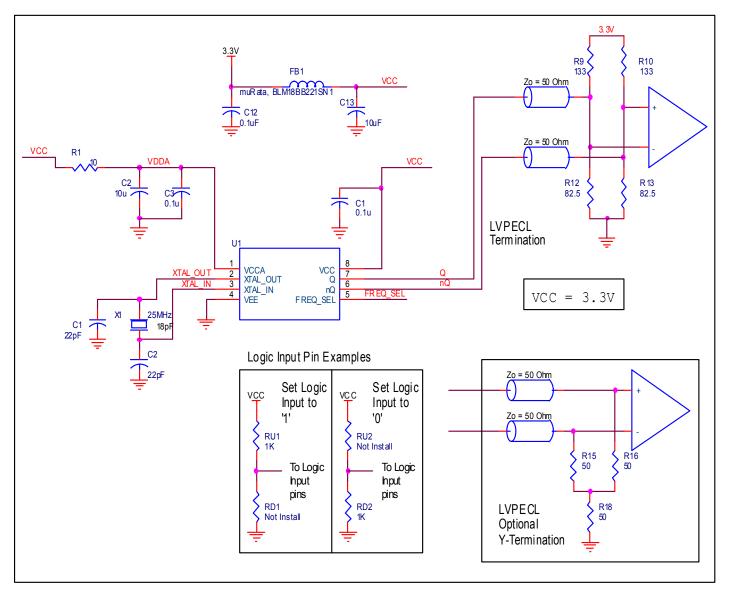


Figure 4. ICS843801I-24 Schematic Example

Power Considerations

This section provides information on power dissipation and junction temperature for the ICS843801I-24. Equations and example calculations are also provided.

1. Power Dissipation.

The total power dissipation for the ICS843801I-24 is the sum of the core power plus the power dissipated in the load(s). The following is the power dissipation for V_{CC} = 3.3V + 5% = 3.465V, which gives worst case results.

NOTE: Please refer to Section 3 for details on calculating power dissipated in the load.

- Power (core)_{MAX} = V_{CC MAX} * I_{EE MAX} = 3.465V * 72mA = 249.48mW
- Power (outputs)_{MAX} = 30mW/Loaded Output pair

Total Power_MAX (3.465V, with all outputs switching) = 249.48mW + 30mW = 279.48mW

2. Junction Temperature.

Junction temperature, Tj, is the temperature at the junction of the bond wire and bond pad directly affects the reliability of the device. The maximum recommended junction temperature is 125°C. Limiting the internal transistor junction temperature, Tj, to 125°C ensures that the bond wire and bond pad temperature remains below 125°C.

The equation for Tj is as follows: Tj = θ_{JA} * Pd_total + T_A

Tj = Junction Temperature

 θ_{JA} = Junction-to-Ambient Thermal Resistance

Pd_total = Total Device Power Dissipation (example calculation is in section 1 above)

T_A = Ambient Temperature

In order to calculate junction temperature, the appropriate junction-to-ambient thermal resistance θ_{JA} must be used. Assuming no air flow and a multi-layer board, the appropriate value is 129.5°C/W per Table 6 below.

Therefore, Tj for an ambient temperature of 85°C with all outputs switching is:

 $85^{\circ}C + 0.279W * 129.5^{\circ}C/W = 121.2^{\circ}C$. This is below the limit of $125^{\circ}C$.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow and the type of board (multi-layer).

Table 6. Thermal Resitance θ_{JA} for 8 Lead TSSOP, Forced Convection

θ_{JA} vs. Air Flow					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	129.5°C/W	125.5°C/W	123.5°C/W		

3. Calculations and Equations.

The purpose of this section is to calculate the power dissipation for the LVPECL output pair.

LVPECL output driver circuit and termination are shown in Figure 5.

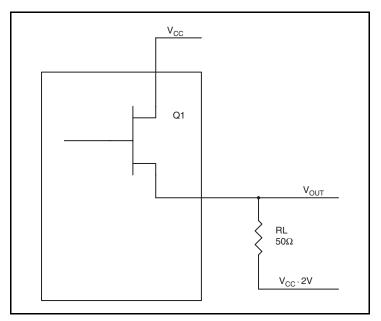


Figure 5. LVPECL Driver Circuit and Termination

To calculate worst case power dissipation into the load, use the following equations which assume a 50 Ω load, and a termination voltage of V_{CC} – 2V.

- For logic high, $V_{OUT} = V_{OH_MAX} = V_{CC_MAX} 0.9V$ ($V_{CC_MAX} - V_{OH_MAX}$) = 0.9V
- For logic low, V_{OUT} = V_{OL_MAX} = V_{CC_MAX} 1.7V (V_{CC_MAX} - V_{OL_MAX}) = 1.7V

Pd_H is power dissipation when the output drives high.

Pd_L is the power dissipation when the output drives low.

 $\mathsf{Pd}_{-}\mathsf{H} = [(\mathsf{V}_{\mathsf{OH}_\mathsf{MAX}} - (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - 2\mathsf{V}))/\mathsf{R}_{\mathsf{L}}] * (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OH}_\mathsf{MAX}}) = [(2\mathsf{V} - (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OH}_\mathsf{MAX}}))/\mathsf{R}_{\mathsf{L}}] * (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OH}_\mathsf{MAX}}) = [(2\mathsf{V} - 0.9\mathsf{V})/50\Omega] * 0.9\mathsf{V} = \mathbf{19.8}\mathsf{mW}$

 $\mathsf{Pd}_{L} = [(\mathsf{V}_{\mathsf{OL}_\mathsf{MAX}} - (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - 2\mathsf{V}))/\mathsf{R}_{L}] * (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OL}_\mathsf{MAX}}) = [(2\mathsf{V} - (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OL}_\mathsf{MAX}}))/\mathsf{R}_{L}] * (\mathsf{V}_{\mathsf{CC}_\mathsf{MAX}} - \mathsf{V}_{\mathsf{OL}_\mathsf{MAX}}) = [(2\mathsf{V} - 1.7\mathsf{V})/50\Omega] * 1.7\mathsf{V} = \mathbf{10.2mW}$

Total Power Dissipation per output pair = Pd_H + Pd_L = **30mW**

Reliability Information

Table 7. θ_{JA} vs. Air Flow Table for a 8 Lead TSSOP

θ _{JA} vs. Air Flow					
Meters per Second	0	1	2.5		
Multi-Layer PCB, JEDEC Standard Test Boards	129.5°C/W	125.5°C/W	123.5°C/W		

Transistor Count

The transistor count for ICS843801I-24 is: 1649

Package Outline and Package Dimensions

Package Outline - G Suffix for 8 Lead TSSOP

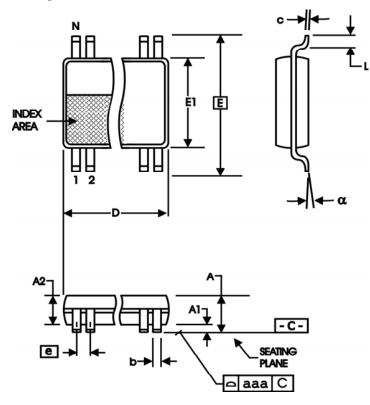


Table 8. Package Dimensions

All Dimensions in Millimeters					
Symbol	Minimum	Maximum			
Ν	8				
Α		1.20			
A1	0.5	0.15			
A2	0.80	1.05			
b	0.19	0.30			
C	0.09	0.20			
D	2.90	3.10			
E	6.40 Basic				
E1	4.30	4.50			
е	0.65 Basic				
L	0.45	0.75			
α	0°	8°			
aaa		0.10			

Reference Document: JEDEC Publication 95, MO-153

Ordering Information

Table 9. Ordering Information

Part/Order Number	Marking	Package	Shipping Packaging	Temperature
843801AGI-24LF	AI24L	"Lead-Free" 8 Lead TSSOP	Tube	-40°C to 85°C
843801AGI-24LFT	Al24L	"Lead-Free" 8 Lead TSSOP	2500 Tape & Reel	-40°C to 85°C

NOTE: Parts that are ordered with an "LF" suffix to the part number are the Pb-Free configuration and are RoHS compliant.



IMPORTANT NOTICE AND DISCLAIMER

RENESAS ELECTRONICS CORPORATION AND ITS SUBSIDIARIES ("RENESAS") PROVIDES TECHNICAL SPECIFICATIONS AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS OR IMPLIED, INCLUDING, WITHOUT LIMITATION, ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for developers skilled in the art designing with Renesas products. You are solely responsible for (1) selecting the appropriate products for your application, (2) designing, validating, and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. Renesas grants you permission to use these resources only for development of an application that uses Renesas products. Other reproduction or use of these resources is strictly prohibited. No license is granted to any other Renesas intellectual property or to any third party intellectual property. Renesas disclaims responsibility for, and you will fully indemnify Renesas and its representatives against, any claims, damages, costs, losses, or liabilities arising out of your use of these resources. Renesas' products are provided only subject to Renesas' Terms and Conditions of Sale or other applicable terms agreed to in writing. No use of any Renesas resources expands or otherwise alters any applicable warranties or warranty disclaimers for these products.

(Rev.1.0 Mar 2020)

Corporate Headquarters

TOYOSU FORESIA, 3-2-24 Toyosu, Koto-ku, Tokyo 135-0061, Japan www.renesas.com

Trademarks

Renesas and the Renesas logo are trademarks of Renesas Electronics Corporation. All trademarks and registered trademarks are the property of their respective owners.

Contact Information

For further information on a product, technology, the most up-to-date version of a document, or your nearest sales office, please visit: www.renesas.com/contact/